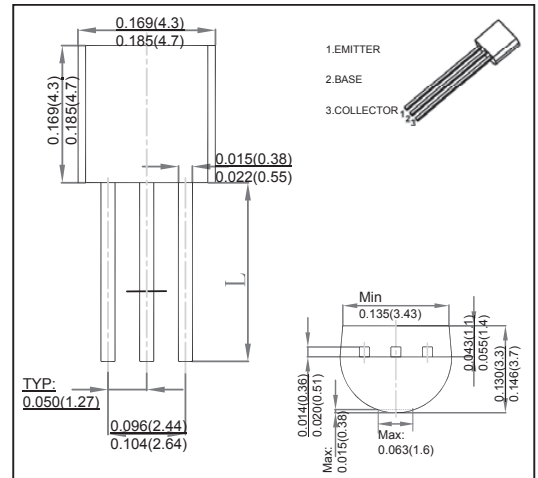


**TO-92 Plastic-Encapsulate Transistors**
**FEATURES**

- Switching and amplification in high voltage
- Applications such as telephony
- Low current
- High voltage
- NPN Transistors

**MECHANICAL DATA**

- Case style: TO-92 molded plastic
- Mounting position: any


**MAXIMUM RATINGS AND CHARACTERISTICS**

@ 25°C Ambient Temperature (unless otherwise noted)

Parameter	Symbol	Rating	Unit
Collector-base voltage	V <sub>CB0</sub>	60	V
Collector-emitter voltage	V <sub>CEO</sub>	30	V
Emitter-base voltage	V <sub>EB0</sub>	5	V
Collector current-continuous	I <sub>C</sub>	0.6	A
Collector Power Dissipation	P <sub>C</sub>	625	mW
Thermal Resistance From Junction To Ambient	R <sub>θJA</sub>	200	°C/W
Junction temperature	T <sub>J</sub>	150	°C
Storage temperature	T <sub>stg</sub>	-55 to +150	°C

Parameter	Symbol	Testconditions	Min	Typ	Max	Unit
Collector-base breakdown voltage	V <sub>(BR)CBO</sub>	I <sub>C</sub> = 0.01mA, I <sub>E</sub> = 0	60			V
Collector-emitter breakdown voltage	V <sub>(BR)CEO</sub>	I <sub>C</sub> = 10 mA, I <sub>B</sub> = 0	30			V
Emitter-base breakdown voltage	V <sub>(BR)EBO</sub>	I <sub>E</sub> = 10 μA, I <sub>C</sub> = 0	5			V
Collector cutoff current	I <sub>CBO</sub>	V <sub>CB</sub> = 500 V, I <sub>E</sub> = 0			0.01	μA
Emitter cutoff current	I <sub>EBO</sub>	V <sub>EB</sub> = 4.0 V, I <sub>C</sub> = 0			0.1	μA
DC current gain	h <sub>FE</sub>	I <sub>C</sub> = 1.0mA, V <sub>CE</sub> = 10V	100		300	
		I <sub>C</sub> = 0.1mA, V <sub>CE</sub> = 10 V	35			
		I <sub>C</sub> = 500mA, V <sub>CE</sub> = 10V	30			
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	I <sub>C</sub> = 500mA, I <sub>B</sub> = 50 mA			1.0	V
Base-emitter saturation voltage *	V <sub>BE(sat)</sub>	I <sub>C</sub> = 500mA, I <sub>B</sub> = 50mA			2.0	V
		I <sub>C</sub> = 50 mA, I <sub>B</sub> = 5 mA			1.0	
Transistor frequency	f <sub>T</sub>	V <sub>CE</sub> = 20V, I <sub>C</sub> = 20mA, f = 100MHz	250			MHz
Collector output capacitance	C <sub>ob</sub>	V <sub>CB</sub> = 10V, I <sub>E</sub> = 0, f = 100MHz			8	pF
Delay time	T <sub>d</sub>	V <sub>CC</sub> = 30V, V <sub>BE</sub> = -0.5V			10	ns
Rise time	T <sub>r</sub>	I <sub>C</sub> = 150mA, I <sub>B1</sub> = 15mA			25	ns
Storage time	T <sub>s</sub>	V <sub>CC</sub> = 30V, I <sub>C</sub> = 150mA			225	ns
Fall time	T <sub>f</sub>	I <sub>B1</sub> = I <sub>B2</sub> = 15mA			60	ns

\* Pulse Test: Pulse Width ≤ 300 us, Duty Cycle ≤ 2.0%.